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What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	Coldfire V2
Core Size	32-Bit Single-Core
Speed	66MHz
Connectivity	CANbus, I ² C, SPI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	33
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 8x12b
Oscillator Type	External
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-VFQFN Exposed Pad
Supplier Device Package	64-QFN-EP (9x9)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mcf5211lcep66

- Error-detection capabilities
- Modem support includes request-to-send (RTS) and clear-to-send (CTS) lines for two UARTs
- Transmit and receive FIFO buffers
- I²C module
 - Interchip bus interface for EEPROMs, LCD controllers, A/D converters, and keypads
 - Fully compatible with industry-standard I²C bus
 - Master and slave modes support multiple masters
 - Automatic interrupt generation with programmable level
- Queued serial peripheral interface (QSPI)
 - Full-duplex, three-wire synchronous transfers
 - Up to four chip selects available
 - Master mode operation only
 - Programmable bit rates up to half the CPU clock frequency
 - Up to 16 pre-programmed transfers
- Fast analog-to-digital converter (ADC)
 - Eight analog input channels
 - 12-bit resolution
 - Minimum 1.125 μ s conversion time
 - Simultaneous sampling of two channels for motor control applications
 - Single-scan or continuous operation
 - Optional interrupts on conversion complete, zero crossing (sign change), or under/over low/high limit
 - Unused analog channels can be used as digital I/O
- Four 32-bit timers with DMA support
 - 12.5 ns resolution at 80 MHz
 - Programmable sources for clock input, including an external clock option
 - Programmable prescaler
 - Input capture capability with programmable trigger edge on input pin
 - Output compare with programmable mode for the output pin
 - Free run and restart modes
 - Maskable interrupts on input capture or output compare
 - DMA trigger capability on input capture or output compare
- Four-channel general purpose timer
 - 16-bit architecture
 - Programmable prescaler
 - Output pulse-widths variable from microseconds to seconds
 - Single 16-bit input pulse accumulator
 - Toggle-on-overflow feature for pulse-width modulator (PWM) generation
 - One dual-mode pulse accumulation channel
- Pulse-width modulation timer
 - Operates as eight channels with 8-bit resolution or four channels with 16-bit resolution
 - Programmable period and duty cycle
 - Programmable enable/disable for each channel
 - Software selectable polarity for each channel
 - Period and duty cycle are double buffered. Change takes effect when the end of the current period is reached (PWM counter reaches zero) or when the channel is disabled.

- Programmable center or left aligned outputs on individual channels
- Four clock sources (A, B, SA, and SB) provide for a wide range of frequencies
- Emergency shutdown
- Two periodic interrupt timers (PITs)
 - 16-bit counter
 - Selectable as free running or count down
- Software watchdog timer
 - 32-bit counter
 - Low-power mode support
- Clock generation features
 - One to 48 MHz crystal, 8 MHz on-chip relaxation oscillator, or external oscillator reference options
 - Trimmed relaxation oscillator
 - Two to 10 MHz reference frequency for normal PLL mode with a pre-divider programmable from 1 to 8
 - System can be clocked from PLL or directly from crystal oscillator or relaxation oscillator
 - Low power modes supported
 - 2^n ($n \leq 0 \leq 15$) low-power divider for extremely low frequency operation
- Interrupt controller
 - Uniquely programmable vectors for all interrupt sources
 - Fully programmable level and priority for all peripheral interrupt sources
 - Seven external interrupt signals with fixed level and priority
 - Unique vector number for each interrupt source
 - Ability to mask any individual interrupt source or all interrupt sources (global mask-all)
 - Support for hardware and software interrupt acknowledge (IACK) cycles
 - Combinatorial path to provide wake-up from low-power modes
- DMA controller
 - Four fully programmable channels
 - Dual-address transfer support with 8-, 16-, and 32-bit data capability, along with support for 16-byte (4×32-bit) burst transfers
 - Source/destination address pointers that can increment or remain constant
 - 24-bit byte transfer counter per channel
 - Auto-alignment transfers supported for efficient block movement
 - Bursting and cycle steal support
 - Software-programmable DMA requesters for the UARTs (3) and 32-bit timers (4)
- Reset
 - Separate reset in and reset out signals
 - Seven sources of reset:
 - Power-on reset (POR)
 - External
 - Software
 - Watchdog
 - Loss of clock
 - Loss of lock
 - Low-voltage detection (LVD)
 - Status flag indication of source of last reset
- Chip integration module (CIM)

1.1.13 General Purpose Timer (GPT)

The general purpose timer (GPT) is a four-channel timer module consisting of a 16-bit programmable counter driven by a seven-stage programmable prescaler. Each of the four channels can be configured for input capture or output compare. Additionally, channel three, can be configured as a pulse accumulator.

A timer overflow function allows software to extend the timing capability of the system beyond the 16-bit range of the counter. The input capture and output compare functions allow simultaneous input waveform measurements and output waveform generation. The input capture function can capture the time of a selected transition edge. The output compare function can generate output waveforms and timer software delays. The 16-bit pulse accumulator can operate as a simple event counter or a gated time accumulator.

1.1.14 Periodic Interrupt Timers (PIT0 and PIT1)

The two periodic interrupt timers (PIT0 and PIT1) are 16-bit timers that provide interrupts at regular intervals with minimal processor intervention. Each timer can count down from the value written in its PIT modulus register or it can be a free-running down-counter.

1.1.15 Pulse-Width Modulation (PWM) Timers

The MCF5213 has an 8-channel, 8-bit PWM timer. Each channel has a programmable period and duty cycle as well as a dedicated counter. Each of the modulators can create independent continuous waveforms with software-selectable duty rates from 0% to 100%. The PWM outputs have programmable polarity, and can be programmed as left aligned outputs or center aligned outputs. For higher period and duty cycle resolution, each pair of adjacent channels ([7:6], [5:4], [3:2], and [1:0]) can be concatenated to form a single 16-bit channel. The module can, therefore, be configured to support 8/0, 6/1, 4/2, 2/3, or 0/4 8-/16-bit channels.

1.1.16 Software Watchdog Timer

The watchdog timer is a 32-bit timer that facilitates recovery from runaway code. The watchdog counter is a free-running down-counter that generates a reset on underflow. To prevent a reset, software must periodically restart the countdown.

1.1.17 Phase-Locked Loop (PLL)

The clock module contains a crystal oscillator, 8 MHz on-chip relaxation oscillator (OCO), phase-locked loop (PLL), reduced frequency divider (RFD), low-power divider status/control registers, and control logic. To improve noise immunity, the PLL, crystal oscillator, and relaxation oscillator have their own power supply inputs: VDDPLL and VSSPLL. All other circuits are powered by the normal supply pins, VDD and VSS.

1.1.18 Interrupt Controller (INTC)

The MCF5213 has a single interrupt controller that supports up to 63 interrupt sources. There are 56 programmable sources, 49 of which are assigned to unique peripheral interrupt requests. The remaining seven sources are unassigned and may be used for software interrupt requests.

1.1.19 DMA Controller

The direct memory access (DMA) controller provides an efficient way to move blocks of data with minimal processor intervention. It has four channels that allow byte, word, longword, or 16-byte burst line transfers. These transfers are triggered by software explicitly setting a $DCR_n[START]$ bit or by the occurrence of certain UART or DMA timer events.

Figure 2 shows the pinout configuration for the 100 LQFP.

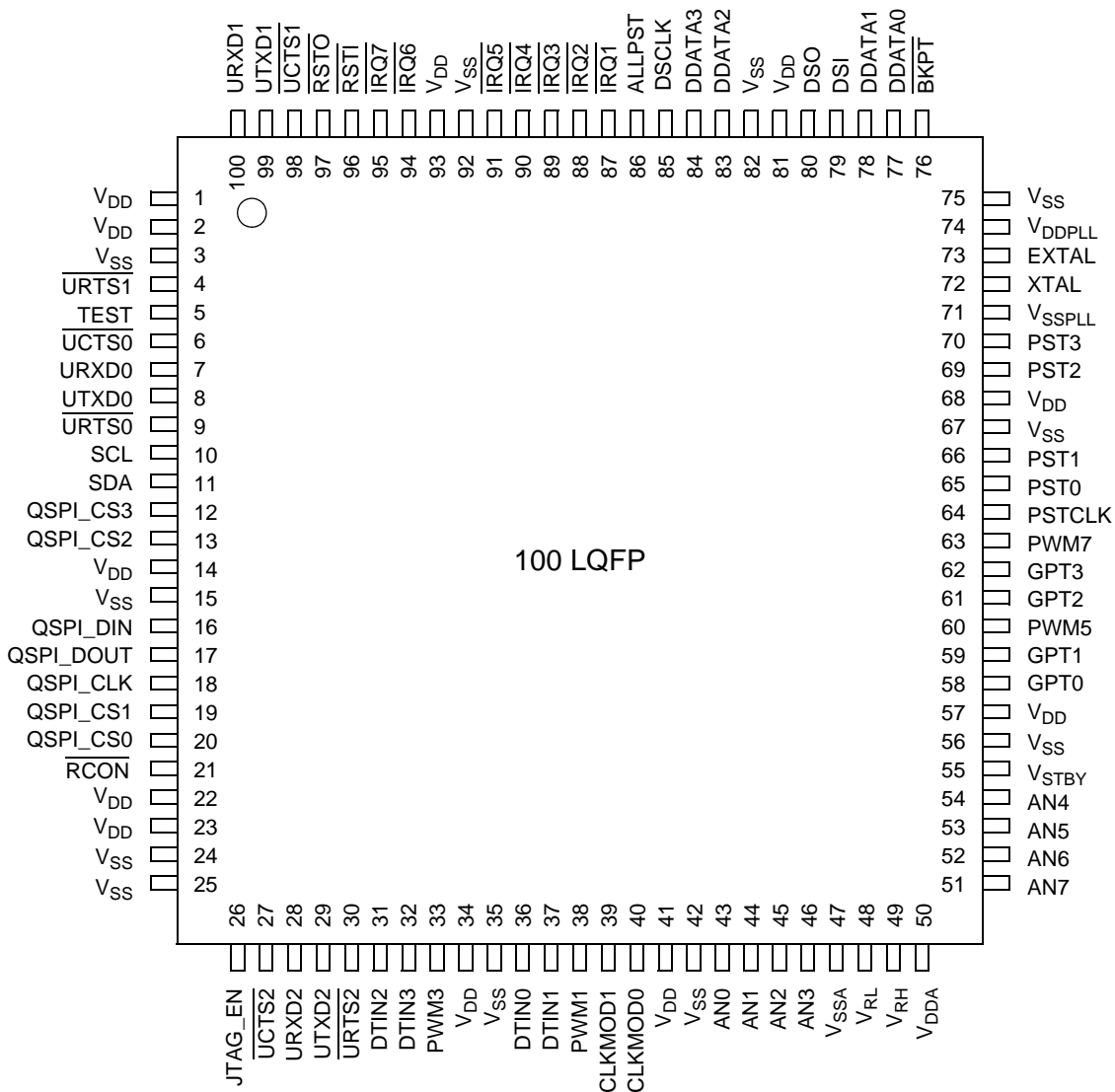


Figure 2. 100 LQFP Pin Assignments

MCF5213 Family Configurations

Figure 3 shows the pinout configuration for the 81 MAPBGA.

	1	2	3	4	5	6	7	8	9
A	V _{SS}	UTXD1	$\overline{\text{RSTI}}$	$\overline{\text{IRQ5}}$	$\overline{\text{IRQ3}}$	ALLPST	TDO	TMS	V _{SS}
B	$\overline{\text{URTS1}}$	URXD1	$\overline{\text{RSTO}}$	$\overline{\text{IRQ6}}$	$\overline{\text{IRQ2}}$	$\overline{\text{TRST}}$	TDI	V _{DD} PLL	EXTAL
C	$\overline{\text{UCTS0}}$	TEST	$\overline{\text{UCTS1}}$	$\overline{\text{IRQ7}}$	$\overline{\text{IRQ4}}$	$\overline{\text{IRQ1}}$	TCLK	V _{SS} PLL	XTAL
D	URXD0	UTXD0	$\overline{\text{URTS0}}$	V _{SS}	V _{DD}	V _{SS}	PWM7	GPT3	GPT2
E	SCL	SDA	V _{DD}	V _{DD}	V _{DD}	V _{DD}	V _{DD}	PWM5	GPT1
F	QSPI_CS3	QSPI_CS2	QSPI_DIN	V _{SS}	V _{DD}	V _{SS}	GPT0	V _{STBY}	AN4
G	QSPI_DOUT	QSPI_CLK	$\overline{\text{RCON}}$	DTIN1	CLKMOD0	AN2	AN3	AN5	AN6
H	QSPI_CS0	QSPI_CS1	DTIN3	DTIN0	CLKMOD1	AN1	V _{SSA}	V _{DDA}	AN7
J	V _{SS}	JTAG_EN	DTIN2	PWM3	PWM1	AN0	V _{RL}	V _{RH}	V _{SSA}

Figure 3. 81 MAPBGA Pin Assignments

Figure 4 shows the pinout configuration for the 64 LQFP and 64 QFN.

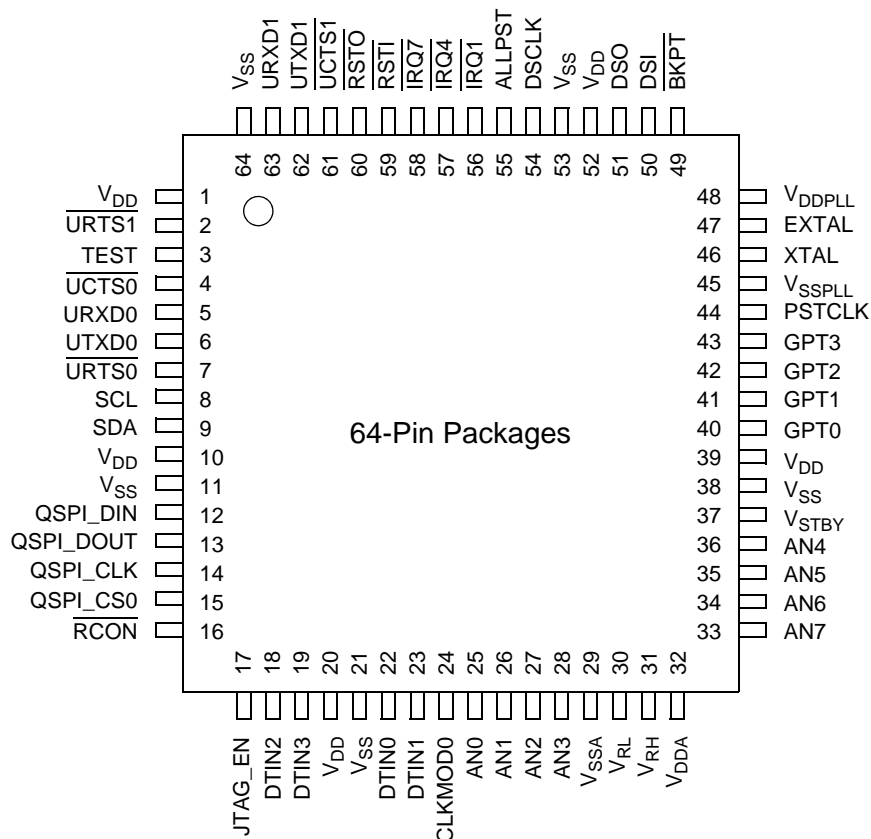


Figure 4. 64 LQFP and 64 QFN Pin Assignments

Table 3 shows the pin functions by primary and alternate purpose, and illustrates which packages contain each pin.

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength / Control ¹	Slew Rate / Control ¹	Pull-up / Pull-down ²	Pin on 100 LQFP	Pin on 81 MAPBGA	Pin on 64 LQFP/QFN
Interrupts	$\overline{\text{IRQ7}}$	—	—	GPIO	Low	FAST	pull-up	95	C4	58
	$\overline{\text{IRQ6}}$	—	—	GPIO	Low	FAST	pull-up	94	B4	—
	$\overline{\text{IRQ5}}$	—	—	GPIO	Low	FAST	pull-up	91	A4	—
	$\overline{\text{IRQ4}}$	—	—	GPIO	Low	FAST	pull-up	90	C5	57
	$\overline{\text{IRQ3}}$	—	—	GPIO	Low	FAST	pull-up	89	A5	—
	$\overline{\text{IRQ2}}$	—	—	GPIO	Low	FAST	pull-up	88	B5	—
	$\overline{\text{IRQ1}}$	SYNCA	PWM1	GPIO	High	FAST	pull-up ⁵	87	C6	56
JTAG/BDM	JTAG_EN	—	—	—	N/A	N/A	pull-down	26	J2	17
	TCLK/ PSTCLK	CLKOUT	—	—	High	FAST	pull-up ⁶	64	C7	44
	TDI/DSI	—	—	—	N/A	N/A	pull-up ⁶	79	B7	50
	TDO/DSO	—	—	—	High	FAST	—	80	A7	51
	TMS /BKPT	—	—	—	N/A	N/A	pull-up ⁶	76	A8	49
	$\overline{\text{TRST}}$ /DSCLK	—	—	—	N/A	N/A	pull-up ⁶	85	B6	54
Mode Selection ⁷	CLKMOD0	—	—	—	N/A	N/A	pull-down ⁷	40	G5	24
	CLKMOD1	—	—	—	N/A	N/A	pull-down ⁷	39	H5	—
	$\overline{\text{RCON}}$ / EZPCS	—	—	—	N/A	N/A	pull-up	21	G3	16
PWM	PWM7	—	—	GPIO	PDSR[31]	PSRR[31]	—	63	D7	—
	PWM5	—	—	GPIO	PDSR[30]	PSRR[30]	—	60	E8	—
	PWM3	—	—	GPIO	PDSR[29]	PSRR[29]	—	33	J4	—
	PWM1	—	—	GPIO	PDSR[28]	PSRR[28]	—	38	J5	—

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength / Control ¹	Slew Rate / Control ¹	Pull-up / Pull-down ²	Pin on 100 LQFP	Pin on 81 MAPBGA	Pin on 64 LQFP/QFN
UART 1	$\overline{\text{UCTS1}}$	SYNCA	URXD2	GPIO	PDSR[15]	PSRR[15]	—	98	C3	61
	$\overline{\text{URTS1}}$	SYNCB	UTXD2	GPIO	PDSR[14]	PSRR[14]	—	4	B1	2
	URXD1	—	—	GPIO	PDSR[13]	PSRR[13]	—	100	B2	63
	UTXD1	—	—	GPIO	PDSR[12]	PSRR[12]	—	99	A2	62
UART 2	$\overline{\text{UCTS2}}$	—	—	GPIO	PDSR[27]	PSRR[27]	—	27	—	—
	$\overline{\text{URTS2}}$	—	—	GPIO	PDSR[26]	PSRR[26]	—	30	—	—
	URXD2	—	—	GPIO	PDSR[25]	PSRR[25]	—	28	—	—
	UTXD2	—	—	GPIO	PDSR[24]	PSRR[24]	—	29	—	—
FlexCAN	CANRX ^{4,11}				N/A	N/A	—	—	—	—
	CANTX ^{4,11}				N/A	N/A	—	—	—	—
VSTBY	VSTBY	—	—	—	N/A	N/A	—	55	F8	37
VDD	VDD	—	—	—	N/A	N/A	—	1,2,14,22,23,34,41,57,68,81,93	D5,E3–E7,F5	1,10,20,39,52
VSS	VSS	—	—	—	N/A	N/A	—	3,15,24,25,35,42,56,67,75,82,92	A1,A9,D4,D6,F4,F6,J1	11,21,38,53,64

¹ The PDSR and PSSR registers are described in the General Purpose I/O chapter. All programmable signals default to 2 mA drive and FAST slew rate in normal (single-chip) mode.

² All signals have a pull-up in GPIO mode.

³ These signals are multiplexed on other pins.

⁴ The multiplexed CANTX and CANRX signals are not available on the MCF5211 or MCF5212.

⁵ For primary and GPIO functions only.

⁶ Only when JTAG mode is enabled.

⁷ CLKMOD0 and CLKMOD1 have internal pull-down resistors; however, the use of external resistors is very strongly recommended.

⁸ For secondary and GPIO functions only.

⁹ $\overline{\text{RSTI}}$ has an internal pull-up resistor; however, the use of an external resistor is very strongly recommended.

¹⁰ For GPIO function. Primary Function has pull-up control within the GPT module.

¹¹ CANTX and CANRX are secondary functions only.

1.5 External Interrupt Signals

Table 8 describes the external interrupt signals.

Table 8. External Interrupt Signals

Signal Name	Abbreviation	Function	I/O
External Interrupts	$\overline{\text{IRQ}}[7:1]$	External interrupt sources.	I

1.6 Queued Serial Peripheral Interface (QSPI)

Table 9 describes the QSPI signals.

Table 9. Queued Serial Peripheral Interface (QSPI) Signals

Signal Name	Abbreviation	Function	I/O
QSPI Synchronous Serial Output	QSPI_DOUT	Provides the serial data from the QSPI and can be programmed to be driven on the rising or falling edge of QSPI_CLK.	O
QSPI Synchronous Serial Data Input	QSPI_DIN	Provides the serial data to the QSPI and can be programmed to be sampled on the rising or falling edge of QSPI_CLK.	I
QSPI Serial Clock	QSPI_CLK	Provides the serial clock from the QSPI. The polarity and phase of QSPI_CLK are programmable.	O
Synchronous Peripheral Chip Selects	QSPI_CS[3:0]	QSPI peripheral chip select; can be programmed to be active high or low.	O

1.7 I²C I/O Signals

Table 10 describes the I²C serial interface module signals.

Table 10. I²C I/O Signals

Signal Name	Abbreviation	Function	I/O
Serial Clock	SCL	Open-drain clock signal for the for the I ² C interface. When the bus is in master mode, this clock is driven by the I ² C module; when the bus is in slave mode, this clock becomes the clock input.	I/O
Serial Data	SDA	Open-drain signal that serves as the data input/output for the I ² C interface.	I/O

2.1 Maximum Ratings

Table 19. Absolute Maximum Ratings^{1, 2}

Rating	Symbol	Value	Unit
Supply voltage	V_{DD}	-0.3 to +4.0	V
Clock synthesizer supply voltage	V_{DDPLL}	-0.3 to +4.0	V
RAM standby supply voltage	V_{STBY}	-0.3 to +4.0	V
Digital input voltage ³	V_{IN}	-0.3 to +4.0	V
EXTAL pin voltage	V_{EXTAL}	0 to 3.3	V
XTAL pin voltage	V_{XTAL}	0 to 3.3	V
Instantaneous maximum current Single pin limit (applies to all pins) ^{4, 5}	I_{DD}	25	mA
Operating temperature range (packaged)	T_A ($T_L - T_H$)	-40 to 85	°C
Storage temperature range	T_{stg}	-65 to 150	°C

¹ Functional operating conditions are given in DC Electrical Specifications. Absolute Maximum Ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond those listed may affect device reliability or cause permanent damage to the device.

² This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (V_{SS} or V_{DD}).

³ Input must be current limited to the I_{DD} value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

⁴ All functional non-supply pins are internally clamped to V_{SS} and V_{DD} .

⁵ The power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If positive injection current ($V_{in} > V_{DD}$) is greater than I_{DD} , the injection current may flow out of V_{DD} and could result in the external power supply going out of regulation. Ensure that the external V_{DD} load shunts current greater than maximum injection current. This is the greatest risk when the MCU is not consuming power (e.g., no clock).

Table 21. Typical Active Current Consumption Specifications

Characteristic	Symbol	Typical ¹ Active (SRAM)	Typical ¹ Active (Flash)	Peak ²	Unit
1 MHz core & I/O	I _{DD}	—	3.48	—	mA
8 MHz core & I/O		7.28	13.37	19.02	
16 MHz core & I/O		12.08	25.08	35.66	
64 MHz core & I/O		40.14	54.62	85.01	
80 MHz core & I/O		49.2	64.09	100.03	
RAM standby supply current <ul style="list-style-type: none"> Normal operation: V_{DD} > V_{STBY} - 0.3 V Transient condition: V_{STBY} - 0.3 V > V_{DD} > V_{SS} + 0.5 V Standby operation: V_{DD} < V_{SS} + 0.5 V 	I _{STBY}	N/A ³ N/A ³ N/A ³		N/A ³ N/A ³ N/A ³	μA mA μA
Analog supply current <ul style="list-style-type: none"> Normal operation Low-power stop 	I _{DDA}	— —	— —	16 50	mA μA

¹ Tested at room temperature with CPU polling a status register. All clocks were off except the UART and CFM (when running from flash memory).

² Peak current measured with all modules active, and default drive strength with matching load.

³ Due to the errata “Non-functional RAM Standby Supply” in the *MCF5213 Device Errata*, V_{STBY} should be connected directly to V_{DD} and cannot be used for RAM standby operation.

2.3 Thermal Characteristics

Table 22 lists thermal resistance values.

Table 22. Thermal Characteristics

	Characteristic		Symbol	Value	Unit
100 LQFP	Junction to ambient, natural convection	Single layer board (1s)	θ _{JA}	53 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ _{JA}	39 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ _{JMA}	42 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ _{JMA}	33 ^{1,3}	°C/W
	Junction to board	—	θ _{JB}	25 ⁴	°C/W
	Junction to case	—	θ _{JC}	9 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ _{jt}	2 ⁶	°C/W
	Maximum operating junction temperature	—	T _j	105	°C

Table 22. Thermal Characteristics (continued)

	Characteristic		Symbol	Value	Unit
81 MAPBGA	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	61 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	35 ^{2,3}	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	50 ^{2,3}	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	31 ^{2,3}	°C/W
	Junction to board	—	θ_{JB}	20 ⁴	°C/W
	Junction to case	—	θ_{JC}	12 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ⁶	°C/W
	Maximum operating junction temperature	—	T_j	105	°C
64 LQFP	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	62 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	43 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Single layer board (1s)	θ_{JMA}	50 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	36 ^{1,3}	°C/W
	Junction to board	—	θ_{JB}	26 ⁴	°C/W
	Junction to case	—	θ_{JC}	9 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ⁶	°C/W
	Maximum operating junction temperature	—	T_j	105	°C
64 QFN	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	68 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	24 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Single layer board (1s)	θ_{JMA}	55 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	19 ^{1,3}	°C/W
	Junction to board	—	θ_{JB}	8 ⁴	°C/W
	Junction to case (bottom)	—	θ_{JC}	0.6 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	3 ⁶	°C/W
	Maximum operating junction temperature	—	T_j	105	°C

¹ θ_{JA} and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

² Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.

³ Per JEDEC JESD51-6 with the board JESD51-7) horizontal.

⁴ Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

⁵ Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

⁶ Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

Table 26. DC Electrical Specifications (continued)¹

Characteristic	Symbol	Min	Max	Unit
Output high voltage (high drive) $I_{OH} = -5 \text{ mA}$	V_{OH}	$V_{DD} - 0.5$	—	V
Output low voltage (high drive) $I_{OL} = 5 \text{ mA}$	V_{OL}	—	0.5	V
Output high voltage (low drive) $I_{OH} = -2 \text{ mA}$	V_{OH}	$V_{DD} - 0.5$	—	V
Output low voltage (low drive) $I_{OL} = 2 \text{ mA}$	V_{OL}	—	0.5	V
Weak internal pull Up device current, tested at $V_{IL} \text{ Max.}^2$	I_{APU}	-10	-130	μA
Input Capacitance ³ <ul style="list-style-type: none"> • All input-only pins • All input/output (three-state) pins 	C_{in}	—	7	pF

¹ Refer to Table 27 for additional PLL specifications.

² Refer to Table 3 for pins having internal pull-up devices.

³ This parameter is characterized before qualification rather than 100% tested.

2.7 Clock Source Electrical Specifications

Table 27. PLL Electrical Specifications

(V_{DD} and $V_{DDPLL} = 2.7$ to 3.6 V , $V_{SS} = V_{SSPLL} = 0 \text{ V}$)

Characteristic	Symbol	Min	Max	Unit
PLL reference frequency range <ul style="list-style-type: none"> • Crystal reference • External reference 	$f_{ref_crystal}$ f_{ref_ext}	2 2	10.0 10.0	MHz
System frequency ¹ <ul style="list-style-type: none"> • External clock mode • On-chip PLL frequency 	f_{sys}	0 $f_{ref} / 32$	66.67 or 80^2 66.67 or 80^2	MHz
Loss of reference frequency ^{3, 5}	f_{LOR}	100	1000	kHz
Self clocked mode frequency ⁴	f_{SCM}	1	5	MHz
Crystal start-up time ^{5, 6}	t_{cst}	—	10	ms
EXTAL input high voltage <ul style="list-style-type: none"> • External reference 	V_{IHEXT}	2.0	V_{DD}	V
EXTAL input low voltage <ul style="list-style-type: none"> • External reference 	V_{ILEXT}	V_{SS}	0.8	V
PLL lock time ^{4, 7}	t_{pll}	—	500	μs
Duty cycle of reference ⁴	t_{dc}	40	60	% f_{ref}

Table 27. PLL Electrical Specifications (continued)

 (V_{DD} and $V_{DDPLL} = 2.7$ to 3.6 V, $V_{SS} = V_{SSPLL} = 0$ V)

Characteristic	Symbol	Min	Max	Unit
Frequency un-LOCK range	f_{UL}	-1.5	1.5	% f_{ref}
Frequency LOCK range	f_{LCK}	-0.75	0.75	% f_{ref}
CLKOUT period jitter ^{4, 5, 8, 9} , measured at f_{SYS} Max <ul style="list-style-type: none"> • Peak-to-peak (clock edge to clock edge) • Long term (averaged over 2 ms interval) 	C_{jitter}	— —	10 .01	% f_{sys}
On-chip oscillator frequency	f_{oco}	7.84	8.16	MHz

¹ All internal registers retain data at 0 Hz.

² Depending on packaging; see Table 2.

³ Loss of Reference Frequency is the reference frequency detected internally, which transitions the PLL into self clocked mode.

⁴ Self clocked mode frequency is the frequency at which the PLL operates when the reference frequency falls below f_{LOR} with default MFD/RFD settings.

⁵ This parameter is characterized before qualification rather than 100% tested.

⁶ Proper PC board layout procedures must be followed to achieve specifications.

⁷ This specification applies to the period required for the PLL to relock after changing the MFD frequency control bits in the synthesizer control register (SYNCR).

⁸ Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{sys} . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via V_{DDPLL} and V_{SSPLL} and variation in crystal oscillator frequency increase the C_{jitter} percentage for a given interval.

⁹ Based on slow system clock of 40 MHz measured at f_{sys} max.

2.8 General Purpose I/O Timing

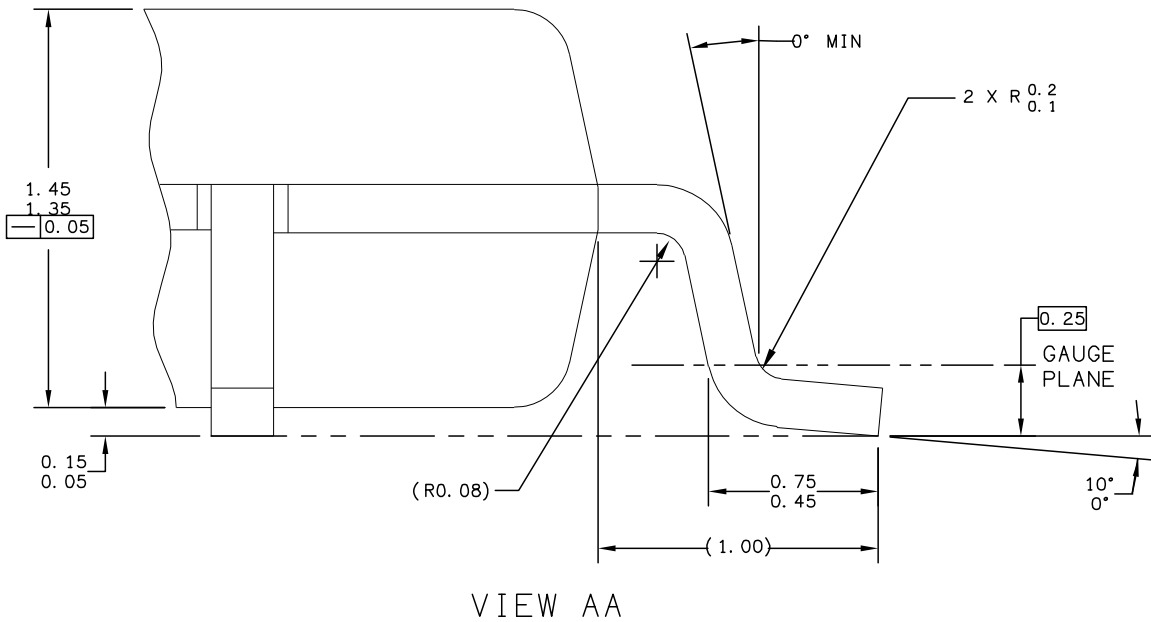
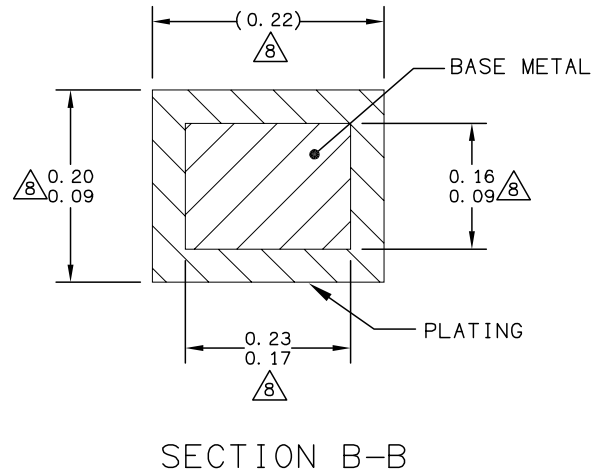
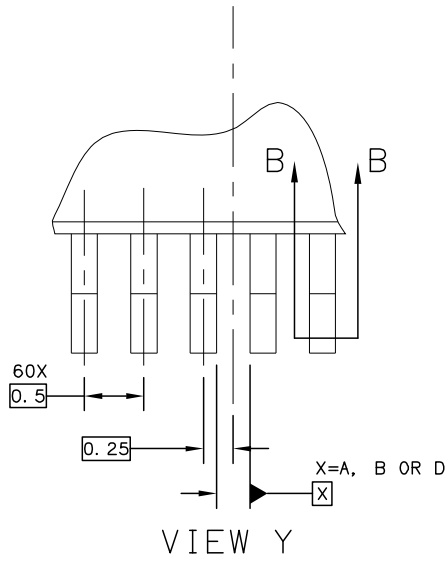
GPIO can be configured for certain pins of the QSPI, DDR Control, timer, UART, and Interrupt interfaces. When in GPIO mode, the timing specification for these pins is given in Table 28 and Figure 5.

The GPIO timing is met under the following load test conditions:

- 50 pF / 50 Ω for high drive
- 25 pF / 25 Ω for low drive

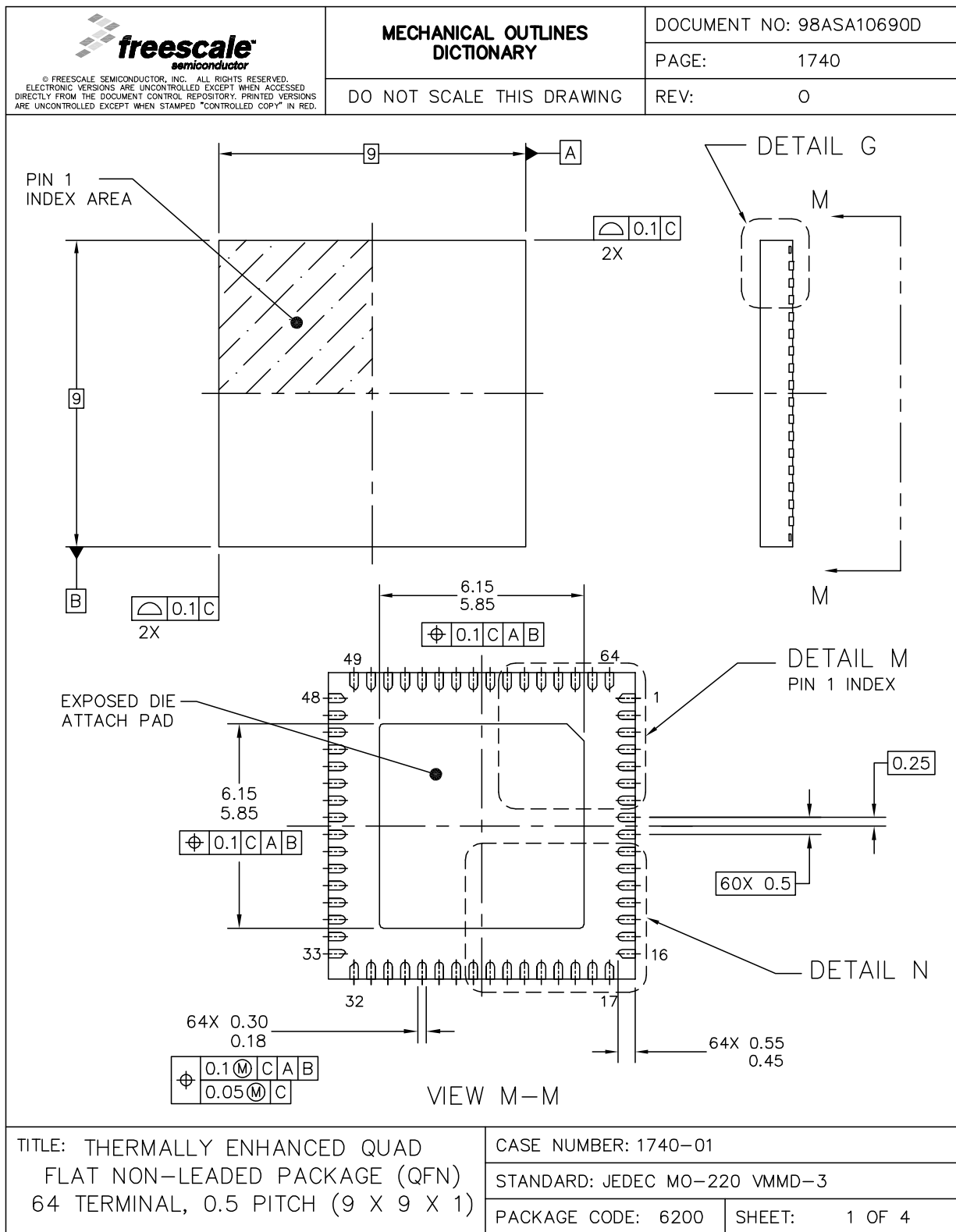
Table 28. GPIO Timing

NUM	Characteristic	Symbol	Min	Max	Unit
G1	CLKOUT High to GPIO Output Valid	t_{CHPOV}	—	10	ns
G2	CLKOUT High to GPIO Output Invalid	t_{CHPOI}	1.5	—	ns
G3	GPIO Input Valid to CLKOUT High	t_{PVCH}	9	—	ns
G4	CLKOUT High to GPIO Input Invalid	t_{CHPI}	1.5	—	ns

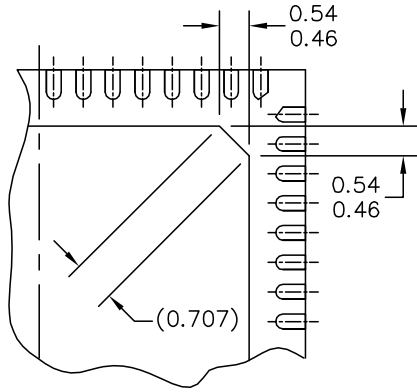


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TITLE: 64LD LQFP, 10 X 10 X 1.4 PKG, 0.5 PITCH, CASE OUTLINE	DOCUMENT NO: 98ASS23234W	REV: D	
	CASE NUMBER: 840F-02	06 APR 2005	
	STANDARD: JEDEC MS-026 BCD		

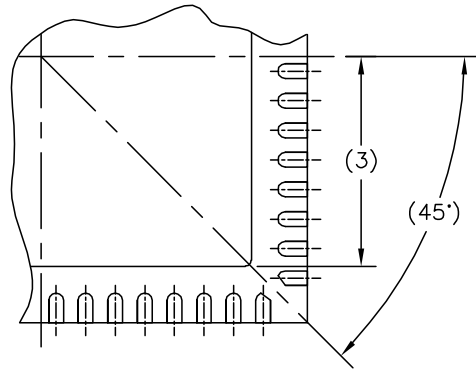
3.2 64 QFN Package



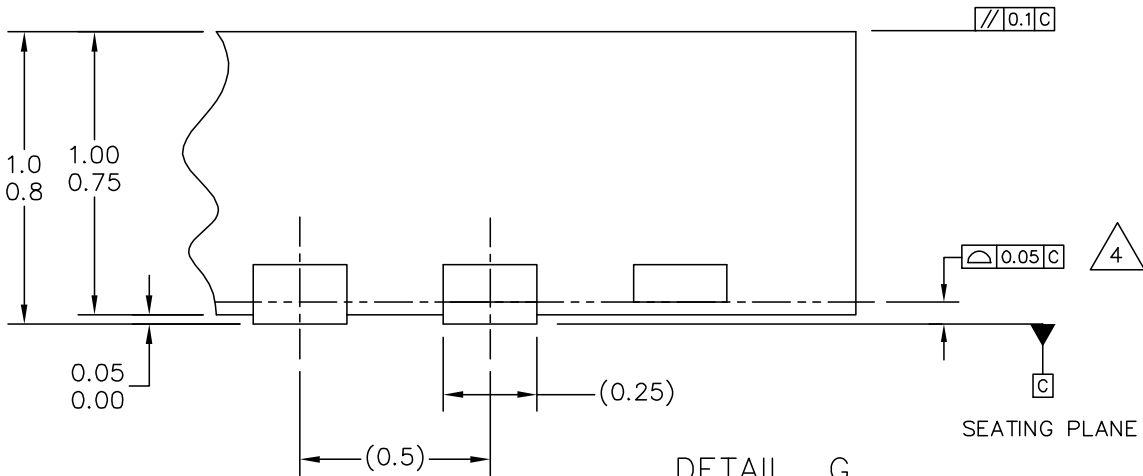
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		PAGE: 1740
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DETAIL M
PREFERRED PIN1 BACKSIDE IDENTIFIER



DETAIL N
PREFERRED CORNER CONFIGURATION



DETAIL G
VIEW ROTATED 90° CW

TITLE: THERMALLY ENHANCED QUAD
FLAT NON-LEADED PACKAGE (QFN)
64 TERMINAL, 0.5 PITCH (9 X 9 X 1)



CASE NUMBER: 1740-01


STANDARD: JEDEC MO-220 VMMD-3

PACKAGE CODE: 6200

SHEET: 2 OF 4

Mechanical Outline Drawings

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		PAGE:	1740
DO NOT SCALE THIS DRAWING		REV:	0
<p>NOTES:</p> <ol style="list-style-type: none"> 1. ALL DIMENSIONS ARE IN MILLIMETERS. 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994. 3. THE COMPLETE JEDEC DESIGNATOR FOR THIS PACKAGE IS: HF-PQFN. 4.  COPLANARITY APPLIES TO LEADS, CORNER LEADS AND DIE ATTACH PAD. 5. MIN METAL GAP SHOULD BE 0.2MM. 			
TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 64 TERMINAL, 0.5 PITCH (9 X 9 X 1)		CASE NUMBER: 1740-01	
		STANDARD: JEDEC MO-220 VMMD-3	
		PACKAGE CODE: 6200	SHEET: 3 OF 4

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				PAGE: 1740	
				REV: 0	
LTR	ORIGINATOR	REVISIONS	DRAFTER	DATE	
0	ERIC TRIPLETT	RELEASED FOR PRODUCTION	TAYLOR LIU	27JUL2005	
TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 64 TERMINAL, 0.5 PITCH (9 X 9 X 1)			CASE NUMBER: 1740-01		
			STANDARD: JEDEC MO-220 VMMD-3		
			PACKAGE CODE: 6200	SHEET:	4 OF 4

4 Revision History

Table 37. Revision History

Revision	Description
2	<ul style="list-style-type: none"> • Formatting, layout, spelling, and grammar corrections. • Added revision history. • Corrected signal names in block diagram to match those in signal description table. • Added the following footnote to the MCF5211 FlexCAN entry: "FlexCAN is available on the MCF5211 only in the 64 QFN package." • Added an entry for standby voltage (V_{STBY}) to the "DC electrical specifications" table. • Deleted the PSTCLK cycle time row in the "Debug AC timing specifications" table. • Changed the frequency above the "Min" and "Max" column headings in the "Debug AC timing specifications" table (was 166 MHz, is 66/80 MHz). • Changed the minimum value for SNR, THD, SFDR, and SINAD in the "ADC parameters" table (was TBD, is "—"). • In the "Pin Functions by Primary and Alternate Purpose" table, changed the value in the "Pull-up/pull-down" column for $\overline{IRQ2}$-$\overline{IRQ6}$ (was "—", is "pull-up"). • Added values for I_{OH} and I_{OL} to the "DC electrical specifications" table. • Added load test condition information to the "General Purpose I/O Timing" section. • Deleted the "80 MHz (Peak)" column from the "Current Consumption in Low-Power Mode" table. • In the "Typical Active Current Consumption Specifications" table, changed the typical active (SRAM) and peak I_{DD} values for the 1 MHz core & I/O entry (were TBD, are "—"). • Changed the I_{STBY} values in the "Typical Active Current Consumption Specifications" table (were 0 or TBD, are "—") and added an explanatory footnote referring to the <i>MCF5213 Device Errata</i>. • Changed the I_{DDA} values in the "Typical Active Current Consumption Specifications" table (were TBD, are 16 mA for normal operation and 50 μA for low-power stop).
3	<ul style="list-style-type: none"> • Formatting, layout, spelling, and grammar corrections. • Synchronized the "Pin Functions by Primary and Alternate Purpose" table in this document and the reference manual. • Restructured the part number summary table to include full orderable parts, and changed its name (was "Part Number Summary", is "Orderable Part Number Summary"). • Updated the family configurations table to show that FlexCAN is not available on the MCF5212. • Added specifications for V_{LVD} and V_{LVDHYS} to the "DC electrical specifications" table.